Sheet 1 of 2 APPLICATION NO.

Form PTO-1449 (REV. 1/06)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 128985		APPLICATION NO. 10/588,146		
1	INFORMAT	ION DISCLOSURE STATEMENT						
(Use several sheets if necessary)				APPLICANT(S) Kenichi SHIRAISHI				
				FILING DATE August 1, 2006		GROUP 2852		
		U.	S. PATEN	T DOCUM	MENTS			
Examiner Initials	Cite No.	Document Number	Date		Name			
/AM/	1	US 2004/0020782 A1	02/05/2004		Cohen et al.			
	2	US 6,341,007 B1	01/22/2002		Nishi et al.			
	3	US 6,400,411 B1	06/04/2002		Bayes et al.			
	4	US 6,549,269 B1	04/15/2003		Nishi et al.			
	5	US 6,591,634 B1	07/15/2003		Morizane			
	6	5,969,441	10/19/1999		Loopstra et al.			
	7	US 6,208,407 B1	03/27/2001		Loopstra			
	8	5,825,043	10/20/1	998	Suwa			
	9	5,623,853	04/29/1	997	Novak et al.			
	10	5,528,118	06/18/1996		Lec			
/AM/	11	5,874,820	02/23/1999		Lee			
		FOR	EIGN PAT	ENT DO	CUMENTS	_		1100
Examiner Initials	Cite No.	Document Number	г	Date	Country		With English Abstract	With English Translation
/AM/	12 .	JP A 08-37149	02/06/1996		Japan		х	х
	13	JP A 04-65603	03/02/1992		Japan		х	
	14	JP A 07-176468	07/14/1995		Japan		х	×
_	15	JP A 57-117238	07/21/1982		Japan		. x	
	16	JP A 2002-14005	01/18/2002		Japan		х	х
	17	JP A 11-16816	01/22/1999		Japan		х	х
-	18	JP A 06-188169	07/08/1994		Japan		х	x
1	19	JP A 10-163099	06/19/	1998	Japan		х	х
/AM/	20	JP A 10-214783	08/11/	1998	Japan		х	х
				DOCUM				
Examiner Initials	Cite No.	(Including Author, Title, Date, Pertinent Pages, etc.)						
EXAMINE	<u> </u>					DATE	CONSIDERE	D
DAAMINE	/Al	lan Mathews/					28/2008	n conforman
Examiner:	Initial i	f citation considered, whether or not cit considered. Include copy of this form v	ation is in vith next o	conforma ommunica	nce with M.P.E.P. 609; draw line t tion to applicant.	unrough	CHARLOTT IL HOT I	n comornai

Sheet 2 of 2 ATTY DOCKET NO. APPLICATION NO. Form PTO-1449 US Dept. of Commerce 10/588,146 PATENT & TRADEMARK OFFICE 128985 (REV. 1/06) INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary) APPLICANT(S) Kenichi SHIRAISHI GROUP FILING DATE 2852 August 1, 2006 U.S. PATENT DOCUMENTS Examiner Cite Name Document Number Date Initials No FOREIGN PATENT DOCUMENTS With With Cite Examiner English Country English Date Initials No. Document Number Abstract Translation х х /AM/ JP A 2000-505958 05/16/2000 Japan 21 х х 05/06/1994 Japan JP A 06-124873 22 х х JP A 08-166475 06/25/1996 Japan 23 x 12/13/1996 Japan х 24 JP A 08-330224 /AM/ OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.) Examiner Cite Initials

DATE CONSIDERED /Alan Mathews/ /Alan Mathews/ Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance Examiner: and not considered. Include copy of this form with next communication to applicant.

Date: January 4, 2007

EXAMINER